

**Search Notes**

Application/Control No.

10/025,969

Examiner

Emmanuel Bayard

Applicant(s)/Patent under  
Reexamination

SPIEGEL ET AL.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	350	7/4/06	26
1	345	7	7
375	345	7/4/06	26

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	350	7/4/06	26

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
26/75	7/4/06	26